

Vishay Siliconix

P-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}$ (Ω) MAX.	I _D (A) a, e	Q _g (TYP.)			
	0.044 at V _{GS} = -10 V	-5.4				
-20	0.054 at V _{GS} = -4.5 V	-4.9	9.5 nC			
	0.082 at V _{GS} = -2.5 V	-3.9				

MICRO FOOT® 1 x 1 S S 3 4 G Backside View Bump Side View

Marking Code: xxxx = 8489

xxx = Date / lot traceability code

Ordering Information:

Si8489EDB-T2-E1 (lead (Pb)-free and halogen-free)

FEATURES

- TrenchFET® power MOSFET
- Small 1 mm x 1 mm max. outline area
- Low 0.548 mm max. profile
- Typical ESD protection 2500 V HBM
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

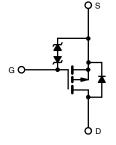
Pb-free

RoHS COMPLIANT

HALOGEN FREE

APPLICATIONS

- · Load switches and charger switches
- Battery management
- For smart phones and tablet PCs



P-Channel MOSFET

PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V _{DS}	-20	V	
Gate-Source Voltage		V _{GS}	± 12	v	
	T _A = 25 °C		-5.4 ^a		
Continuous Dusin Comment (T. 150 °C)	T _A = 70 °C		-4.3 ^a		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	-3.6 b		
	T _A = 70 °C		-2.8 ^b	A	
Pulsed Drain Current (t = 300 μs)		I _{DM}	-20		
0 " 0 5 5 1 0 1	T _C = 25 °C	,	-1.5 ^a		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	-0.65 ^b		
	T _A = 25 °C		1.8 ^a		
Maniana Danian Disainatian	T _A = 70 °C	Б.	1.1 ^a	10/	
Maximum Power Dissipation	T _A = 25 °C	P _D	0.78 b	W	
	T _A = 70 °C		0.5 b		
Operating Junction and Storage Temperature F	T _J , T _{stg}	-55 to 150			
Dockers Deflow Conditions C	VPR	_	260	°C	
Package Reflow Conditions ^c	IR/Convection		260		

Notes

- a. Surface mounted on 1" \times 1" FR4 board with full copper, t = 10 s.
- b. Surface mounted on 1" x 1" FR4 board with minimum copper, t = 10 s.
- c. Refer to IPC/JEDEC® (J-STD-020), no manual or hand soldering.
- d. In this document, any reference to case represents the body of the MICRO FOOT device and foot is the bump.
- e. Based on $T_A = 25$ °C.

THERMAL RESISTANCE RATINGS							
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT		
Maximum Junction-to-Ambient a, b	t = 10 s	В	55	70	°C/W		
Maximum Junction-to-Ambient c, d	t = 10 s	R _{thJA}	125	160	C/VV		

Notes

- a. Surface mounted on 1" x 1" FR4 board with full copper.
- b. Maximum under steady state conditions is 100 °C/W.
- c. Surface mounted on 1" x 1" FR4 board with minimum copper.
- d. Maximum under steady state conditions is 190 $^{\circ}\text{C/W}.$

SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)								
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT			
Static	•			•		•		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-20	=	-	V		
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 A	-	-15	-	mV/°C		
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = -250 μA	-	2.4	-			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = -250 \mu A$	-0.5	-	-1.2	V		
Cata Sauraa Laakaga	la a a	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 4.5 \text{ V}$	-	-	± 1	μΑ		
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$	-	-	± 5			
Zero Gate Voltage Drain Current	1	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	-1			
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 70 ^{\circ}\text{C}$	-	-	-10			
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	-10	-	-	Α		
		$V_{GS} = -10 \text{ V}, I_D = -1.5 \text{ A}$	-	0.036	0.044			
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = -4.5 \text{ V}, I_D = -1.5 \text{ A}$ - 0.045 $V_{GS} = -2.5 \text{ V}, I_D = -1 \text{ A}$ - 0.065				Ω		
	, ,							
Forward Transconductance ^a g_{fs} $V_{DS} = -10 \text{ V}, I_D = -1.5 \text{ A}$		-	10	-	S			
Dynamic ^b								
Input Capacitance	C _{iss}			765	-			
Output Capacitance	C _{oss}	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	125	-	pF		
Reverse Transfer Capacitance	C _{rss}		-	115	-			
Total Cata Charge	Qg	$V_{DS} = -10 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -1.5 \text{ A}$	-	17.5	27	nC		
Total Gate Charge			-	8.6	13			
Gate-Source Charge	Q _{gs}	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -1.5 \text{ A}$	-	1.5	-			
Gate-Drain Charge	Q _{gd}		-	2.6	-			
Gate Resistance	R_g	V _{GS} = -0.1 V, f = 1 MHz	-	14	-	Ω		
Turn-On Delay Time	t _{d(on)}		-	27	50			
Rise Time	t _r	$V_{DD} = -10 \text{ V}, R_{L} = 10 \Omega$	-	20	40			
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -1.5 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$	-	50	100			
Fall Time	t _f		-	25	50			
Turn-On Delay Time	t _{d(on)}		-	6	15	ns		
Rise Time	t _r			8	20			
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -1.5 \text{ A}, V_{GEN} = -8 \text{ V}, R_g = 1 \Omega$	-	68	130	1		
Fall Time	t _f		-	28	60	1		

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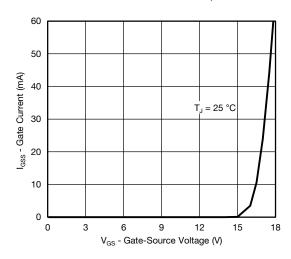
SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)								
PARAMETER	R SYMBOL TEST CONDITIONS			TYP.	MAX.	UNIT		
Drain-Source Body Diode Characteristics								
Continuous Source-Drain Diode Current	Is	T _A = 25 °C	-	-	-1.5	Α		
Pulse Diode Forward Current	I _{SM}		-	-	-20			
Body Diode Voltage	V_{SD}	$I_S = -1.5 \text{ A}, V_{GS} = 0 \text{ V}$	-	-0.8	-1.2	V		
Body Diode Reverse Recovery Time	t _{rr}		-	25	50	ns		
Body Diode Reverse Recovery Charge	Q _{rr}	 I _F = -1.5 A, dl/dt = 100 A/μs, T _J = 25 °C	-	9	20	nC		
Reverse Recovery Fall Time	t _a	$\begin{bmatrix} 1 & -1.5 \text{ A}, \text{ GI/GI} = 100 \text{ A/} \mu\text{s}, & 1 & 1 & 25 \end{bmatrix}$	-	15	-	ns		
Reverse Recovery Rise Time	t _b		-	10	-	115		

Notes

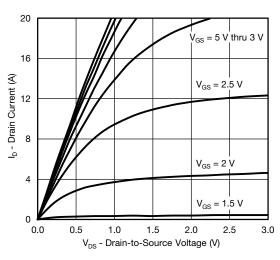
- a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

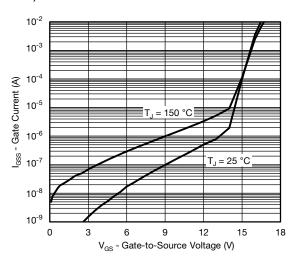
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



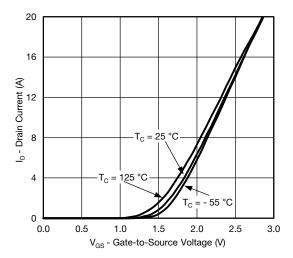




Output Characteristics



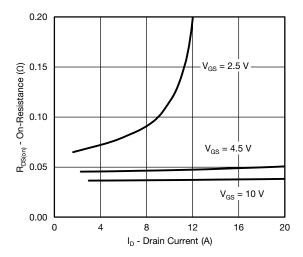
Gate Current vs. Gate-Source Voltage



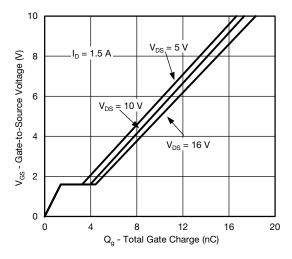
Transfer Characteristics



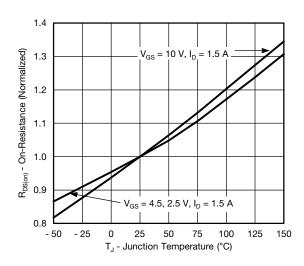
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



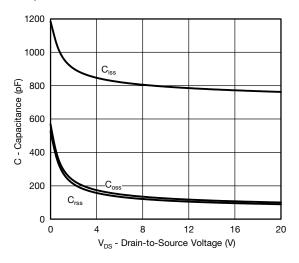
On-Resistance vs. Drain Current and Gate Voltage



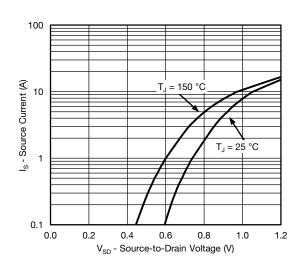
Gate Charge



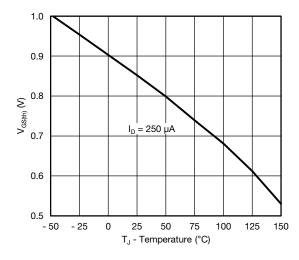
On-Resistance vs. Junction Temperature



Capacitance

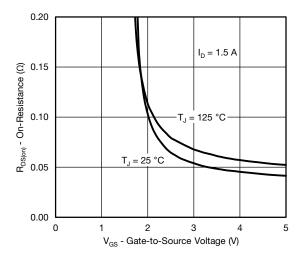


Source-Drain Diode Forward Voltage

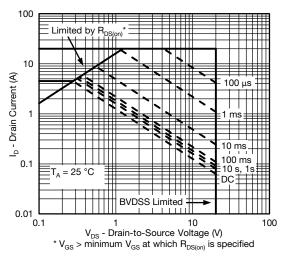




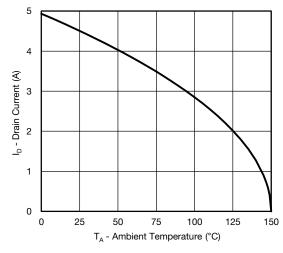
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



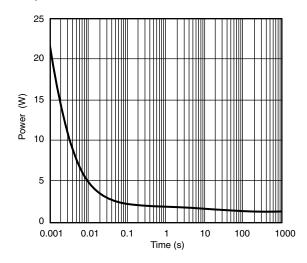
On-Resistance vs. Gate-to-Source Voltage



Safe Operating Area, Junction-to-Ambient



Current Derating a



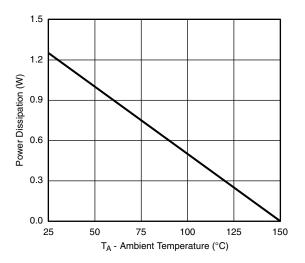
Single Pulse Power, Junction-to-Ambient

Note

• When mounted on 1" x 1" FR4 with full copper.

Note

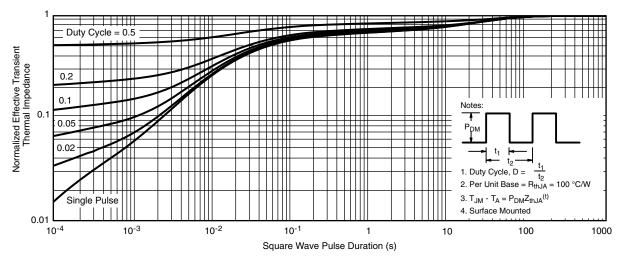
a. The power dissipation P_D is based on T_J (max.) = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



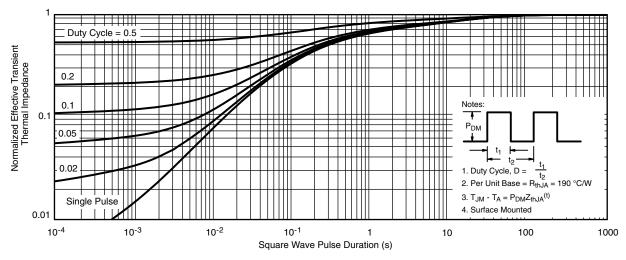
Power Derating



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient (1" x 1" FR4 Board with Full Copper)



Normalized Thermal Transient Impedance, Junction-to-Ambient (1" x 1" FR4 Board with Minimum Copper)

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?62752.

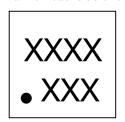


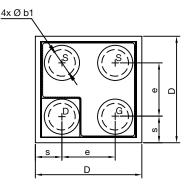
www.vishay.com

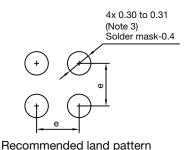
Vishay Siliconix

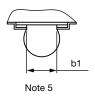
MICRO FOOT®: 4-Bumps (1 mm x 1 mm, 0.5 mm Pitch, 0.286 mm Bump Height)

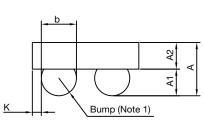
Mark on backside of die











Notes

- 1. Bumps are 95.5/3.8/0.7 Sn/Ag/Cu.
- 2. Backside surface is coated with a Ti/Ni/Ag layer.
- 3. Non-solder mask defined copper landing pad.
- 4. Laser mark on the backside surface of die.
- 5. "b1" is the diameter of the solderable substrate surface, defined by an opening in the solder resist layer solder mask defined.
- 6. is the location of pin 1

DIM.		MILLIMETERS		INCHES			
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
Α	0.458	0.504	0.550	0.0180	0.0198	0.0217	
A1	0.214	0.250	0.286	0.0084	0.0098	0.0113	
A2	0.244	0.254	0.264	0.0096	0.0100	0.0104	
b	0.297	0.330	0.363	0.0117	0.0130	0.0143	
b1	0.250			0.0098			
е	0.500			0.0197			
S	0.210	0.230	0.250	0.0083	0.0091	0.0096	
D	0.920	0.960	1.000	0.0362	0.0378	0.0394	
K	0.029	0.065	0.102	0.0011	0.0026	0.0040	

Note

• Use millimeters as the primary measurement.

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DWG: 6039

Revision: 27-Apr-15 1 Document Number: 69370



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Vishay

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